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APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/555,853	11/01/2005	Yasuo Ohama	37904-0058	4615
28481 7590 11/01/2007 TIAJOLOFF & KELLY CHRYSLER BUILDING, 37TH FLOOR			EXAMINER	
			SONG, MATTHEW J	
405 LEXINGTON AVENUE NEW YORK, NY 10174		ART UNIT	PAPER NUMBER	
			1792	
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			MAIL DATE	DELIVERY MODE
			11/01/2007	PAPER

Please find below and/or attached an Office communication concerning this application or proceeding.

The time period for reply, if any, is set in the attached communication.

	Application No.	Applicant(s)		
	10/555,853	OHAMA, YASUO		
Office Action Summary	Examiner	Art Unit		
	Matthew J. Song	1792		
The MAILING DATE of this communication app Period for Reply	ears on the cover sheet w	vith the correspondence address		
A SHORTENED STATUTORY PERIOD FOR REPLY WHICHEVER IS LONGER, FROM THE MAILING DOWN THE MEDICAL STATE SIX (6) MONTHS from the mailing date of this communication.  If NO period for reply is specified above, the maximum statutory period of Failure to reply within the set or extended period for reply will, by statute Any reply received by the Office later than three months after the mailing earned patent term adjustment. See 37 CFR 1.704(b).	ATE OF THIS COMMUN 36(a). In no event, however, may a vill apply and will expire SIX (6) MO , cause the application to become A	ICATION. a reply be timely filed  ENTHS from the mailing date of this communication. ABANDONED (35 U.S.C. § 133).		
Status				
1) Responsive to communication(s) filed on  2a) This action is <b>FINAL</b> . 2b) This  3) Since this application is in condition for alloware closed in accordance with the practice under E	action is non-final. nce except for formal ma	•		
Disposition of Claims	·			
4) Claim(s) 1-25 is/are pending in the application. 4a) Of the above claim(s) is/are withdray 5) Claim(s) is/are allowed. 6) Claim(s) 1-25 is/are rejected. 7) Claim(s) is/are objected to. 8) Claim(s) are subject to restriction and/o	wn from consideration.			
Application Papers				
9) The specification is objected to by the Examine 10) The drawing(s) filed on is/are: a) accomplicated any not request that any objection to the Replacement drawing sheet(s) including the correct 11) The oath or declaration is objected to by the Example 11.	epted or b)  objected to drawing(s) be held in abeya ion is required if the drawin	ance. See 37 CFR 1.85(a). g(s) is objected to. See 37 CFR 1.121(d).		
Priority under 35 U.S.C. § 119				
<ul> <li>12) Acknowledgment is made of a claim for foreign priority under 35 U.S.C. § 119(a)-(d) or (f).</li> <li>a) All b) Some * c) None of:</li> <li>1. Certified copies of the priority documents have been received.</li> <li>2. Certified copies of the priority documents have been received in Application No</li> <li>3. Copies of the certified copies of the priority documents have been received in this National Stage application from the International Bureau (PCT Rule 17.2(a)).</li> <li>* See the attached detailed Office action for a list of the certified copies not received.</li> </ul>				
Attachment(s)  1) Notice of References Cited (PTO-892)  2) Notice of Draftsperson's Patent Drawing Review (PTO-948)  3) Information Disclosure Statement(s) (PTO/SB/08) Paper No(s)/Mail Date 11/1/05.	Paper No	Summary (PTO-413) o(s)/Mail Date Informal Patent Application		

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## **DETAILED ACTION**

## Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
  - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1-25 are rejected under 35 U.S.C. 103(a) as being unpatentable over Kemmochi et al (US 6,641,663) in view of Sato et al (US 6,136,092) and Ohama (US 2002/0192409 A1).

Kemmochi et al teaches a quartz crucible comprising an outer layer formed by melting natural silica powder (purified natural quartz) (col 3, ln 20-45); a first transparent layer 18 made of natural quartz formed on the inside thereof (col 3, ln 40-65; col 5, ln 1-20 and claim 21); and a second transparent layer 16 made of synthetic quartz glass formed over the entire inside surface, this clearly suggests 1.0 L (Fig 1; Fig 3; col 3, ln 35-67; col 5, ln 1-20 and claim 31).

Kemmochi et al teaches an outer translucent silica glass layer (col 3, ln 20-30). Kemmochi et al does not teach an opaque outer layer.

In a method of forming a quartz crucible, note entire reference, Sato et al teaches an opaque outer layer and a transparent inner layer (col 3, ln 30-40).

It would have been obvious to a person of ordinary skill in the art at the time of the invention to modify Kemmochi et al by using an opaque outer layer, as taught by Sato et al, because an opaque outer layer has a higher strength than transparent quartz (col 1, ln 40-50).

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The combination of Kemmochi et al and Sato et al does not explicitly teach the first transparent layer has a thickness of 0.4-5.0 mm. The combination of Kemmochi et al and Sato et al teaches a side portion has a thickness of 10.0 mm with an inner layer of 0.2-1.0 mm and a bulk layer of 6.5-9.4 mm, thus a first transparent layer having a thickness of 0.4-5.0 mm can be inferred based on a total thickness of 10.0 mm. Furthermore, Ohama et al teaches a quartz crucible comprising a translucent outer layer of quartz, a transparent inner layer and an intermediate layer ([0013]-[0016]). Ohama et al also teaches the thickness of the intermediate layer of 0.5 mm or more ([0023]).

It would have been obvious to a person of ordinary skill in the art at the time of the invention to modify the combination of Kemmochi et al and Sato et al by using an intermediate layer of 0.5 mm or more, as taught by Ohama et al, to provide a crucible with sufficient strength to the crucible ([0019]).

Referring to claim 2 and 22, the combination of Kemmochi et al, Sato et al and Ohama et al teaches a second transparent layer thickness of 0.2-1.0 mm ('663 col 3, ln 50-67).

Referring to claim 3, the combination of Kemmochi et al, Sato et al and Ohama et al teaches 1.0 L, as discussed previously.

Referring to claim 4, see the remarks for claims 2-3 above.

Referring to claims 5, 18-20 and 25, the combination of Kemmochi et al, Sato et al and Ohama et al teaches an opaque silica with an OH group concentration of 80 ppm or less ('092 col 3, ln 55-67) and an inner layer with an OH concentration of 100-400 ppm to a depth of 1 mm, with an inner layer thickness of 0.5 mm ('409 [0023]), which suggests an intermediate layer OH concentration of 100-400 ppm for the intermediate layer. Overlapping ranges are prima facie

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obvious (MPEP 2144.05). In regards to the relation limitation, the ranges overlap the claimed ranges thus the relationship would have been obvious to one of ordinary skill in the art.

Referring to claims 6 and 15, the combination of Kemmochi et al, Sato et al and Ohama et al teaches forming an opaque outer layer, a transparent transition layer (first transparent layer) and a transparent inner layer (second transparent layer), wherein the second transparent layer extends over the entire inner surface of the crucible (1.0L), as discussed previously. The combination of Kemmochi et al, Sato et al and Ohama et al also teaches flowing silica powder, melting and vitrifying to form the transparent layer ('409 [0037] and '663 col 4, ln 10 to col 5, ln 30).

Referring to claims 7-8 and 10-14, the combination of Kemmochi et al, Sato et al and Ohama et al does not teach the claimed number of brown rings in relation to the surface level of the melt. First, this limitation is merely an intended use because the limitation does not provide any structural limitation, only a measurement of brown rings after pulling a single crystal, which is a method limitation. The combination of Kemmochi et al, Sato et al and Ohama et al is capable of performing the claimed intended use, thus meets the claimed limitation. Second, the crucible taught by the combination of Kemmochi et al, Sato et al and Ohama et al is expected to have the claimed number of brown rings in the relation to the surface level of a silicon melt if performed in the claimed intended use because the combination of Kemmochi et al, Sato et al and Ohama et al teaches the same crucible as applicant in terms of crucible material and OH concentration. Therefore, a similar crucible is expected to have similar properties after performing a particular intended use. The same arguments apply to claim 11, which claims a similar intended use limitation of an etching treatment or sandblasting because an etching treatment or sandblasting is

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an intended use and the crucible is expected to have similar properties after performing the claimed intended use.

Referring to claim 9, the combination of Kemmochi et al, Sato et al and Ohama et al teaches a mixture of natural and synthetic quartz can be used to form the inner layer ('409 [0029]).

Referring to claim 16, the combination of Kemmochi et al, Sato et al and Ohama et al teaches 1.0L, as discussed previously.

Referring to claim 17, the combination of Kemmochi et al, Sato et al and Ohama et al teaches an inner layer of 0.2-1.0 mm ('663 col 3, ln 50-67). Overlapping ranges are held to be prima facie obvious (MPEP 2144.05).

Referring to claim 21, 23 and 24, the combination of Kemmochi et al, Sato et al and Ohama et al teaches an opaque outer layer, a first transparent layer having a thickness within the claimed range and a second transparent layer, as discussed previously. The combination of Kemmochi et al, Sato et al and Ohama et al also teaches the entire first transparent layer and the second transparent layer extend over the entire inner surface, thus would extend over the two distances of 0.15 and 0.55 times the total distance.

## Conclusion

Any inquiry concerning this communication or earlier communications from the examiner should be directed to Matthew J. Song whose telephone number is 571-272-1468. The examiner can normally be reached on M-F 9:00-5:00.

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If attempts to reach the examiner by telephone are unsuccessful, the examiner's

supervisor, Michael Barr can be reached on 571-272-1414. The fax phone number for the

organization where this application or proceeding is assigned is 571-273-8300.

Information regarding the status of an application may be obtained from the Patent

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like assistance from a USPTO Customer Service Representative or access to the automated

information system, call 800-786-9199 (IN USA OR CANADA) or 571-272-1000.

Matthew J Song Examiner

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MJS

October 28, 2007

/Robert Kunemund/ Robert Kunemund Primary Examiner

TC 1700